Signetics

Linear Products

DESCRIPTION

The NE5210 is a 7k Ω transimpedance wide band, low noise amplifier with differential outputs, particularly suitable for signal recovery in fiber-optic receivers. The part is ideally suited for many other RF applications as a general purpose gain block.

NE5210 Transimpedance Amplifier (280MHz)

Preliminary Specification

FEATURES

- Low noise: 3.5pA/VHz
- Single 5V supply
- Large bandwidth: 280MHz
- Differential outputs
- Low input/output impedances
- High power supply rejection ratio
- High overload threshold current
- Wide dynamic range
- 7k Ω differential transresistance

APPLICATIONS

- Fiber-optic receivers, analog and digital
- Current-to-voltage converters
- Wideband gain block
- Medical and scientific instrumentation
- Sensor preamplifiers
- Single-ended to differential conversion
- Low noise RF amplifiers
- RF signal processing

ORDERING INFORMATION

DESCRIPTION	TEMPERATURE RANGE	ORDER CODE	
14-Pin Plastic SO	0 to +70°C	NE5210D	

ABSOLUTE MAXIMUM RATINGS

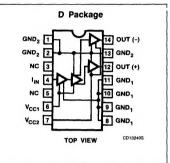
SYMBOL	PARAMETER	RATING	UNIT	
V _{CC}	Power supply	6	V	
TA	Operating ambient temperature range	0 to +70	°C	
Tj	Operating junction temperature range	-55 to +150	°C	
TSTG	Storage temperature range	-65 to +150	°C	
PDMAX	Power dissipation $T_A = 25^{\circ}C$ (still air) ¹	1.0	w	
IINMAX	Maximum input current ²	5	mA	

NOTES:

1. Maximum dissipation is determined by the operating ambient temperature and the thermal resistance: $\theta_{JA} = 125^{\circ}C/W$.

2. The use of a pull-up resistor to V_{CC} for the PIN diode, is recommended.

PIN CONFIGURATION



NOTE:

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			
			Min	Тур	Max	UNIT
V _{IN}	Input bias voltage		0.6	0.8	0.95	v
V _{O±}	Output bias voltage		2.8	3.3	3.7	v
V _{OS}	Output offset voltage			0	80	mV
lcc	Supply current		21	26	32	mA
IOMAX	Output sink/source current1		3	4		mA
IIN	Input current (2% linearity)	Test Circuit 8, Procedure 2	± 120	± 160		μA
I _{INMAX}	Maximum input current overload threshold	Test Circuit 8, Procedure 4	± 160	± 240		μΑ

RECOMMENDED OPERATING CONDITIONS

Transimpedance Amplifier (280MHz)

SYMBOL	SYMBOL PARAMETER		UNIT	
V _{CC}	Supply voltage	4.5 to 5.5	v	
TA	Ambient temperature range	0 to +70	°C	
Tj	Junction temperature range	0 to +90	°C	

1. Test condition: output quiescent voltage variation is less than 100mV for 3mA load current.

DC ELECTRICAL CHARACTERISTICS Min and Max limits apply over operating temperature range at $V_{CC} = 5V$, unless otherwise specified. Typical data applies at $V_{CC} = 5V$ and $T_A = 25^{\circ}C$.

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SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			
			Min	Тур	Max	UNIT
RT	Transresistance (differential output)	DC tested, $R_L = \infty$ Test Circuit 8, Procedure 1	4.9	7	10	kΩ
Ro	Output resistance (differential output)	DC tested	16	30	42	Ω
R _T	Transresistance (single-ended output)	DC tested, $R_L = \infty$	2.45	3.5	5	kΩ
R _O	Output resistance (single-ended output)	DC tested	8	15	21	Ω
f _{3dB}	Bandwidth (-3dB)	Test Circuit 1, T _A = 25°C	200	280		MHz
R _{IN}	Input resistance			60		Ω
CIN	Input capacitance			7.5		pF
ΔR/ΔV	Transresistance power supply sensitivity	$V_{CC} = 5 \pm 0.5 V$		9.6	20	%/V
ΔR/ΔT	Transresistance ambient temperature sensitivity	$\Delta T_{A} = T_{A MAX} - T_{A MIN}$		0.05	0.1	%/°C
IN	RMS noise current spectral density (referred to input)	$f = 10MHz, T_A = 25^{\circ}C,$ Test Circuit 2		3.5	6	pA/√H
I _T c	Integrated RMS noise current over the bandwidth (referred to input) $C_S = 0^1$	$T_A = 25^{\circ}C$ Test Circuit 2 $\Delta f = 100MHz$ $\Delta f = 200MHz$		37 56		nA nA
	C _S = 1	$\Delta f = 300MHz$ $\Delta f = 100MHz$ $\Delta f = 200MHz$ $\Delta f = 300MHz$		71 40 66 89		nA nA nA nA
PSRR	Power supply rejection ratio ² ($V_{CC1} = V_{CC2}$)	Dc tested, $\Delta V_{CC} = 0.1V$ Equivalent AC test circuit 3	20	36		dB
PSRR	Power supply rejection ratio ² (V _{CC1})	DC tested, $\Delta V_{CC} = 0.1V$ Equivalent AC test circuit 4	20	36		dB
PSRR	Power supply rejection ratio ² (V _{CC2})	DC tested, $\Delta V_{CC} = 0.1V$ Equivalent AC test circuit 5		65		dB
PSRR	Power supply rejection ratio ² (ECL configuration)	f = 0.1MHz, Test Circuit 6		23		dB
Vomax	Maximum output voltage swing differential	R _L = ∞ Test Circuit 8, Procedure 3	2.4	3.2		V _{P-P}
VINMAX	Maximum input amplitude for output duty cycle of 50±5% ³	Test Circuit 7	650			mV _{P-P}
t _R	Rise time for 50 mV _{P-P} output signal ⁴	Test Circuit 7		0.8	1.2	ns

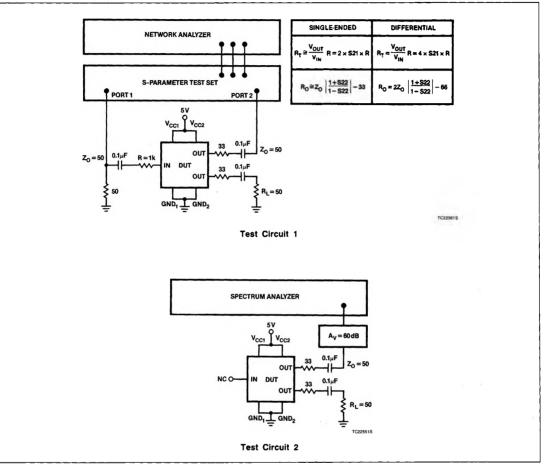
NOTES:

1. Package parasitic capacitance amounts to about 0.2pF.

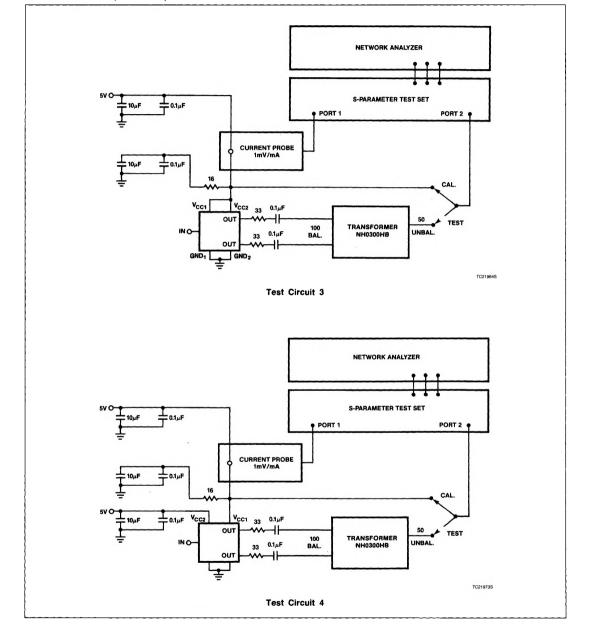
3. Guaranteed by linearity and overload tests. 4. t_R defined as 20 - 80% rise time. It is guaranteed by a -3dB bandwidth test.

^{2.} PSRR is output referenced and is circuit board layout dependent at higher frequencies. For best performance use RF filter in V_{CC} line.

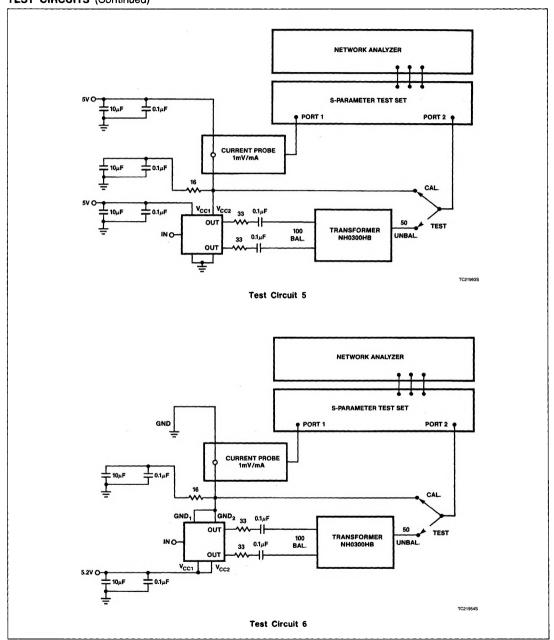
TEST CIRCUITS



TEST CIRCUITS (Continued)

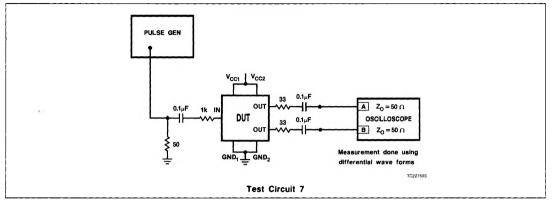


TEST CIRCUITS (Continued)



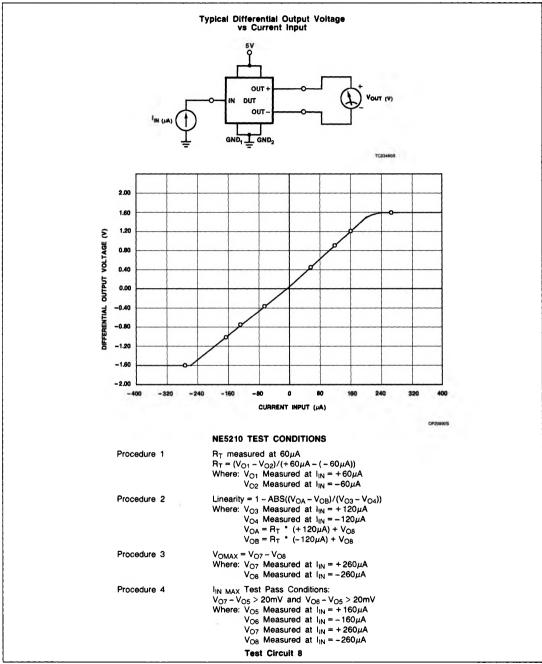
NE5210



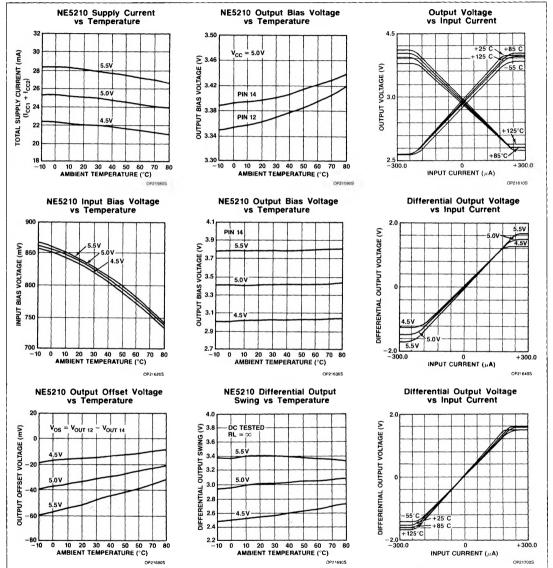


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TEST CIRCUITS (Continued)



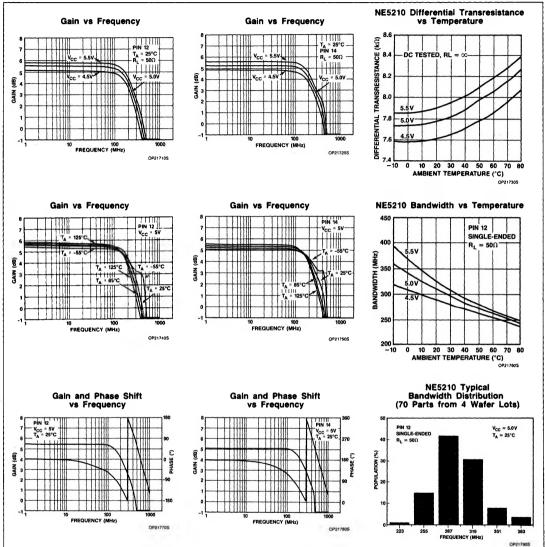
TYPICAL PERFORMANCE CHARACTERISTICS



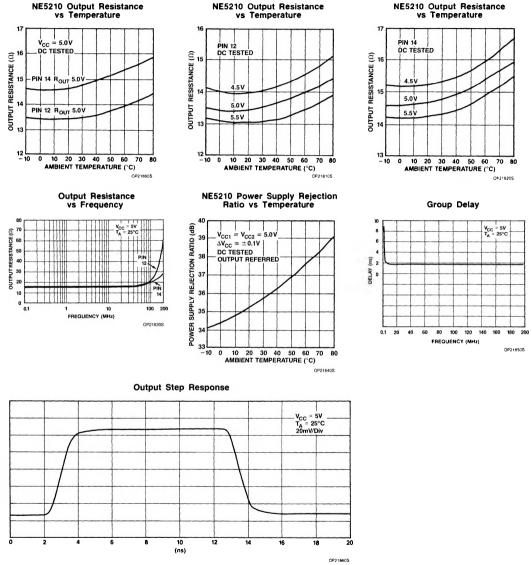
NE5210

Transimpedance Amplifier (280MHz)

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



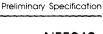
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NE5210 Output Resistance

Transimpedance Amplifier (280MHz)

TYPICAL PERFORMANCE CHARACTERISTICS (Continued)



NE5210 Output Resistance

NE5210

Preliminary Specification

Transimpedance Amplifier (280MHz)

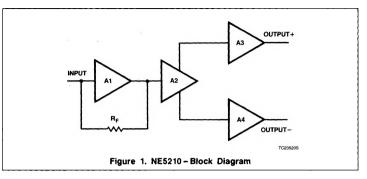
THEORY OF OPERATION

Transimpedance amplifiers have been widely used as the preamplifier in fiber-optic receivers. The NE5210 is a wide bandwidth (typically 280MHz) transimpedance amplifier designed primarily for input currents requiring a large dynamic range, such as those produced by a laser diode. The maximum input current before output stage clipping occurs at typically 240µA. The NE5210 is a bipolar transimpedance amplifier which is current driven at the input and generates a differential voltage signal at the outputs. The forward transfer function is therefore a ratio of the differential output voltage to a given input current with the dimensions of ohms. The main feature of this amplifier is a wideband, low-noise input stage which is desensitized to photodiode capacitance variations. When connected to a photodiode of a few picoFarads, the frequency response will not be degraded significantly. Except for the input stage, the entire signal path is differential to provide improved powersupply rejection and ease of interface to ECL type circuitry. A block diagram of the circuit is shown in Figure 1. The input stage (A1) employs shunt-series feedback to stabilize the current gain of the amplifier. The transresistance of the amplifier from the current source to the emitter of Q3 is approximately the value of the feedback resistor. $R_{\rm E} = 3.6 k \Omega$. The gain from the second stage (A2) and emitter followers (A3 and A4) is about two. Therefore, the differential transresistance of the entire amplifier, RT is

$$R_{T} = \frac{V_{OUT}(diff)}{I_{IN}} = 2R_{F} = 2(3.6K) = 7.2k\Omega.$$

The single-ended transresistance of the amplifier is typically $3.6k\Omega$.

The simplified schematic in Figure 2 shows how an input current is converted to a differential output voltage. The amplifier has a single input for current which is referenced to Ground 1. An input current from a laser diode. for example, will be converted into a voltage by the feedback resistor Rc. The transistor Q1 provides most of the open loop gain of the circuit, A_{VOL}≈70. The emitter follower Q₂ minimizes loading on Q1. The transistor Q4, resistor R7, and VB1 provide level shifting and interface with the Q15-Q16 differential pair of the second stage which is biased with an internal reference, V_{B2}. The differential outputs are derived from emitter followers Q11-Q12 which are biased by constant current sources. The collectors of Q11-Q12 are bonded to an external pin, V_{CC2}, in order to reduce the feedback to the input stage. The output impedance is about 17Ω single-ended.



For ease of performance evaluation, a 33 Ω resistor is used in series with each output to match to a 50 Ω test system.

BANDWIDTH CALCULATIONS

The input stage, shown in Figure 3, employs shunt-series feedback to stabilize the current gain of the amplifier. A simplified analysis can determine the performance of the amplifier. The equivalent input capacitance, $C_{\rm IN}$, in parallel with the source, $l_{\rm S}$ is approximately 7.5pF, assuming that $C_{\rm S}$ = 0 where $C_{\rm S}$ is the external source capacitance.

Since the input is driven by a current source the input must have a low input resistance. The input resistance, R_{IN} , is the ratio of the incremental input voltage, V_{IN} , to the corresponding input current, I_{IN} and can be calculated as:

$$R_{IN} - \frac{V_{IN}}{l_{IN}} = \frac{R_F}{1 + A_{VOI}} = \frac{3.6k}{71} = 51\Omega.$$

More exact calculations would yield a higher value of 60Ω .

Thus C_{IN} and R_{IN} will form the dominant pole of the entire amplifier;

$$f_{-3dB} = \frac{1}{2\pi R_{\rm IN} C_{\rm IN}}$$

Assuming typical values for $R_F = 3.6k\Omega$, $R_{IN} = 60\Omega$, $C_{IN} = 7.5pF$

$$f_{-3dB} = \frac{1}{2\pi \ 7.5 \text{pF} \ 60} = 354 \text{MHz}.$$

The operating point of Q1, Figure 2, has been optimized for the lowest current noise without introducing a second dominant pole in the pass-band. All poles associated with subsequent stages have been kept at sufficiently high enough frequencies to yield an overall single pole response. Although wider bandwidths have been achieved by using a cascode input stage configuration, the present solution has the advantage of a very uniform, highly desensitized frequency response because the Miller effect dominates over the external photodiode and stray capacitances. For example, assuming a source capacitance of 1pF, input stage voltage gain of 70, $R_{\rm IN}=60\Omega$ then the total input capacitance, $C_{\rm IN}=(1+7.5)$ pF which will lead to only a 12% bandwidth reduction.

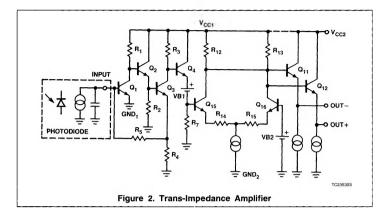
NOISE

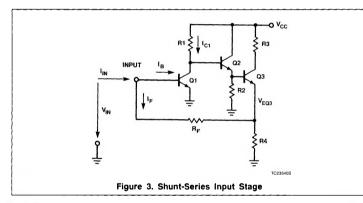
Most of the currently installed fiber-optic systems use non-coherent transmission and detect incident optical power. Therefore, receiver noise performance becomes very important. The input stage achieves a low input referred noise current (spectral density) of 3.5pA/VHz. The transresistance configuration assures that the external high value bias resistors often required for photodiode biasing will not contribute to the total noise system noise. The equivalent input RMS noise current is strongly determined by the quiescent current of Q1, the feedback resistor RF, and the bandwidth; however, it is not dependent upon the internal Miller-capacitance. The measured wideband noise was 66nA in a 200MHz bandwidth.

DYNAMIC RANGE CALCULATIONS

The electrical dynamic range can be defined as the ratio of maximum input current to the peak noise current:

Electrical dynamic range, D_E , in a 200MHz bandwidth assuming $l_{\rm INMAX}=240\mu A$ and a wideband noise of $l_{EO}=66nA_{RMS}$ for an external source capacitance of $C_S=1\,pF.$





$$D_{E} = \frac{(Max. input current)}{(Peak noise current)}$$
$$\approx 20 \log \frac{(240 \times 10^{\circ})}{(240 \times 10^{\circ})}$$

$$= 20 \log \frac{(240\mu A)}{(93nA)} = 68dB.$$

In order to calculate the optical dynamic range the incident optical power must be considered.

For a given wavelength λ ;

Energy of one Photon =
$$\frac{hc}{\lambda}$$
 watt sec (Joule)

Where h = Planck's Constant = 6.6×10^{-34} Joule sec.

c = speed of light = 3×10^8 mt/sec $c/\lambda = optical frequency$

No. of incident photons/sec =
$$\frac{P}{hc}$$
 where
P = optical incident power $\frac{\lambda}{\lambda}$

December 1988

No.

No. of generated electrons/sec =
$$\eta \cdot \frac{1}{h}$$

where η = quantum efficiency

р

$$I = \eta \cdot hc \cdot e$$
 Amps (Coulombs/sec.)

where e = electron charge = 1.6×10^{-19} Coulombs

n•e

Responsivity
$$R = \frac{hc}{hc}$$
 Amp/watt
I = P·R

Assuming a data rate of 400 Mbaud (Bandwidth, B = 200MHz), the noise parameter Z may be calculated as:1

$$Z = \frac{I_{EO}}{qB} = \frac{66 \times 10^{-9}}{(1.6 \times 10^{-19})(200 \times 10^{6})} = 2063$$

where Z is the ratio of _{RMS} noise output to the
peak response to a single hole-electron pair.
Assuming 100% photodetector quantum effi-
ciency, half mark/half space digital transmis-
sion, 850nm lightwave and using Gaussian
approximation, the minimum required optical
power to achieve
$$10^{-9}$$
 BER is:

$$P_{avMIN} = 12 \frac{hc}{\lambda} B Z = 12 2.3 \times 10^{-19}$$

200 × 10⁶ 2063
= 1139nW = -29.4dBm,

where h is Planck's Constant, c is the speed of light, λ is the wavelength. The minimum input current to the NE5210, at this input power is:

$$= \frac{q P_{avMIN} \frac{\lambda}{hc}}{2.3 \times 10^{-9} \times 1.6 \times 10^{-15}}$$
$$= \frac{1139 \times 10^{-9} \times 1.6 \times 10^{-15}}{2.3 \times 10^{-19}}$$
$$= 792 nA.$$

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Choosing the maximum peak overload current of $I_{avMAX} = 240 \mu A$, the maximum mean optical power is:

$$P_{avMAX} = \frac{hc \ l_{avMAX}}{\lambda \ q} = \frac{2.3 \times 10^{-19}}{1.6 \times 10^{-19}} 240 \times 10^{-6}$$

= 345mW or -4.6dBm.

Thus the optical dynamic range, Do is:

 $D_0 = P_{avMAX} - P_{avMIN} = -4.6 - (-29.4) = 24.8 dB.$

This represents the maximum limit attainable with the NE5210 operating at 200MHz bandwidth, with a half mark/half space digital transmission at 850nm wavelength.

APPLICATION INFORMATION

Package parasitics, particularly ground lead inductances and parasitic capacitances, can significantly degrade the frequency response. Since the NE5210 has differential outputs which can feed back signals to the input by parasitic package or board layout capacitances, both peaking and attenuating type frequency response shaping is possible. Constructing the board layout so that Ground 1 and Ground 2 have very low impedance paths has produced the best results. This was accomplished by adding a ground-plane stripe underneath the device connecting Ground 1, Pins 8-11, and Ground 2, Pins 1 and 2 on opposite ends of the SO14 package. This ground-plane stripe also provides isolation between the output return currents flowing to either V_{CC2} or Ground 2 and the input photodiode currents to flowing to Ground 1. Without this ground-plane stripe and with large lead inductances on the board, the part may be unstable and oscillate near

NE5210

Transimpedance Amplifier (280MHz)

800MHz. The easiest way to realize that the part is not functioning normally is to measure the DC voltages at the outputs. If they are not close to their quiescent values of 3.3V (for a 5V supply), then the circuit may be oscillating. Input pin layout necessitates that the photodiode be physically very close to the input and Ground 1. Connecting Pins 3 and 5 to Ground 1 will tend to shield the input ut it will also tend to increase the capacitance on the input and slightly reduce the bandwidth.

As with any high-frequency device, some precautions must be observed in order to enjoy reliable performance. The first of these is the use of a well-regulated power supply. The supply must be capable of providing varying amounts of current without significantly changing the voltage level. Proper supply bypassing requires that a good quality 0.1 μ F high-frequency capacitor be inserted between V_{CC1} and V_{CC2}, preferably a chip capacitor, as close to the package pins as possible. Also, the parallel combination of

 0.1μ F capacitors with 10μ F tantalum capacitors from each supply, V_{CC1} and V_{CC2} , to the ground plane should provide adequate decoupling. Some applications may require an RF choke in series with the power supply line. Separate analog and digital ground leads must be maintained and printed circuit board ground plane should be employed whenever possible.

Figure 4 depicts a 50Mb/s TTL fiber-optic receiver using the BPF31, 850nm LED, the NE5210 and the NE5214 post amplifier.

